

Data sheet acquired from Harris Semiconductor SCHS098D - Revised October 2003

CD40107B Types

CMOS Dual 2-input NAND Buffer/Driver

High-Voltage Type (20-Volt Rating)

The CD40107B is a dual 2-input NAND buffer/driver containing two independent 2-input NAND buffers with open-drain single n-channel transistor outputs. This device features a wired-OR capability and high output sink current capability (136 mA typ. at $V_{\mbox{DD}}$ = 10 V, $V_{\mbox{DS}}$ = 1 V). The CD40107B is supplied in 8-lead hermetic dual-in-line ceramic packages (F3A suffix), 8-lead dual-in-line plastic packages (E suffix), 8-lead small-outline packages (M, M96, MT, and PSR suffixes), and 8-lead thin shrink small-outline packages (PW and PWR suffixes).

Features:

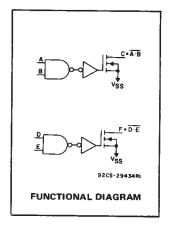
- 32 times standard B-Series output current drive sinking capability - 136 mA typ. @ VDD = 10 V, VDS = 1 V
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 µA at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- 5-V, 10-V, and 15-V parametric ratings
- Noise margin, full package temperature range, R_L to $V_{DD} = 10 \text{ k}\Omega$:

1 V at V_{DD} = 5 V

2 V at V_{DD} = 10 V

2.5 V at V_{DD} = 15 V

* Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"



Applications

- Driving relays, lamps, LEDs
- Line driver
- Level shifter (up or down)

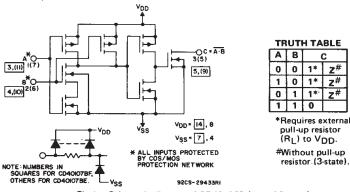


Fig.1 - Schematic diagram of CD40107B (one of 2 gates)

DRAIN-TO-SOURCE VOLTAGE (Vns) -V 92CS-29444RI

Fig.2 - Typical output low (sink) current characteristics.

MAXIMUM RATINGS, Absolute-Maximum Values:

At distance $1/16 \pm 1/32$ inch $(1.59 \pm 0.79$ mm) from case for 10s max +265°C



For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

LIF	1111170	
MIN.	MAX.	UNITS
3	18	V

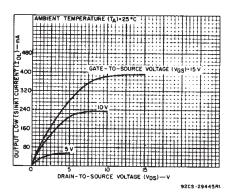


Fig.3 - Minimum output low (sink) current characteristics.

CD40107B Types

DYNAMIC ELECTRICAL CHARACTERISTICS at $T_A = 25^{\circ}$ C, $C_L = 50$ pF, input $t_r, t_f = 20$ ns

	TEST CONDITIONS		LIMITS			
CHARACTERISTIC		V _{DD} Volts	Тур.	Max.	UNITS	
Propagation Delay:	R _L * = 120 Ω	5	100	200	ns	
High-to-Low, tpHL		10	45	90		
		15	30	60		
	R _L * = 120 Ω	5	100	200	ns	
Low-to-High, tpLH		10	60	120		
		15	50	100		
Transition Time:	R _L * = 120 Ω	5	50	100	ns	
High-to-Low, tTHL		10	20	40		
Tighto-cow, CIHL		15	10	20		
Low-to-High, t _{TLH}	R _L * = 120 Ω	5	50	100	ns	
		10	35	70		
		15	25	50		
Average Input Capacitance, CIN	Any Input		5	7.5	pF	
Average Output Capacitance, COUT	Any Output		30	_	pF	

^{*} R_L is external pull-up resistor to V_{DD}.

STATIC ELECTRICAL CHARACTERISTICS

CHARACTER-	CON	OITIO	NS	LIMITS AT INDICATED TEMPERATURE			S (°C)					
13110	Vo	VIN	V_{DD}	L					+25			
	(V)	(V)	(V)	-55	-40	+85	+125	Min.	Тур.	Max.		
Quiescent Device	_	0,5	5	1	1	30	30	_	0.02	1		
Current		0,10	10	2	2	60	60	_	0.02	2	١.	
IDD Max.		0,15	15	4	4	120	120	_	0.02	4	μΑ	
	_	0,20	20	20	20	600	600	_	0.04	20		
Output Low	0.4	0,5	5	21	20	14	12	16	32	_		
(Sink) Current	1	0,5	5	44	42	30	25	34	68	_	mA	
IOL Min.	0.5	0,10	10	49	46	32	28	37	74	_		
- OL	1	0,10	10	89	85	60	51	68	136			
	0.5	0,15	15	66	63	44	38	50	100	-	'''^	
Output High (Source) Current IOH Min.	* 4			No Internal Pull-Up Device								
Input Low	4.5	-	5		1	.5		: -	_	1.5		
Voltage	9	-	10		,	3		_	-	3		
VIL Max.*	13.5	_	15		4	1		-	_	4	v	
Input High Voltage VIH Min.*	0.5,4.5	_	5		3	.5		3.5	_	_	v	
	1,9	_	10			7		7	_]	
	1.5,13.5	1	15		11			11	-	_		
Input Current IJN Max.		0,18	18	±0.1	±0.1	±1	±1	-	±10 ⁻⁵	±0.1	μΑ	
Output Leakage Current IOZ Max.	18	0,18	18	2	2	20	20	-	10 ⁻⁴	2	μΑ	

^{*} Measured with external pull-up resistor, RL = 10 k Ω to VDD.

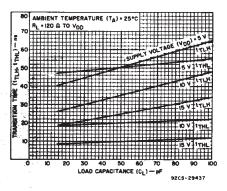


Fig.4 — Typical transition time as a function of load capacitance.

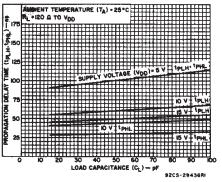


Fig.5 — Typical propagation delay time as a function of load capacitance.

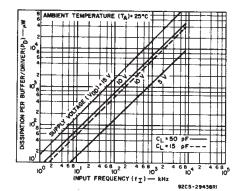


Fig.6 — Typical power dissipation as a function of input frequency.

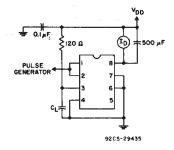
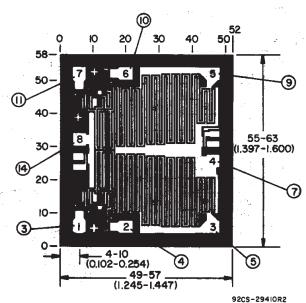


Fig. 7 — Power-dissipation test circuit for CD401078E.

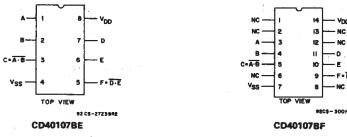
CD40107B Types



NOTE: NOS. IN PADS FOR CD40107BE NOS. OUTSIDE CHIP FOR CD40107BF

Dimensions and Pad Layout for CD401078H.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10⁻³ inch).



TERMINAL ASSIGNMENTS

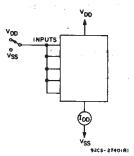


Fig.8 - Quiescent-device current test circuit.

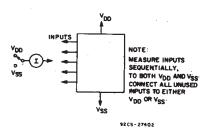


Fig. 9 - Input-current test circuit.

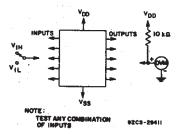


Fig. 10 — Input-voltage test circuit.

Special Considerations for CD40107B

Limiting Capacitive Currents for CL > 500 pF, V_{DD} > 15 V.
 For V_{DD} > 15 V, and load capacitance

For VDD > 15 V, and load capacitance (CL) from output to ground > 500 pF, an external 25 Ω series limiting resistor should be inserted between the output terminal and CL. No external resistor is necessary if CL < 500 pF or VDD < 15 V.

2. Driving Inductive Loads

When using the CD40107B to drive inductive loads, the load should be shunted with a diode to prevent high voltages from developing across the CD40107B output.

14 LEADS SHOWN

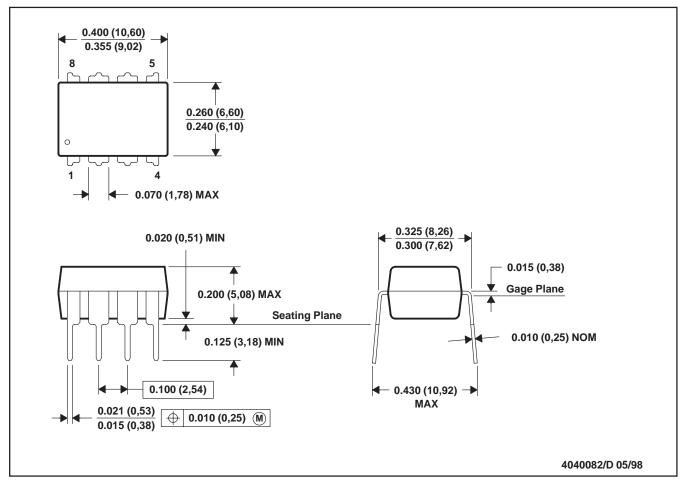


NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE



NOTES: A. All linear dimensions are in inches (millimeters).

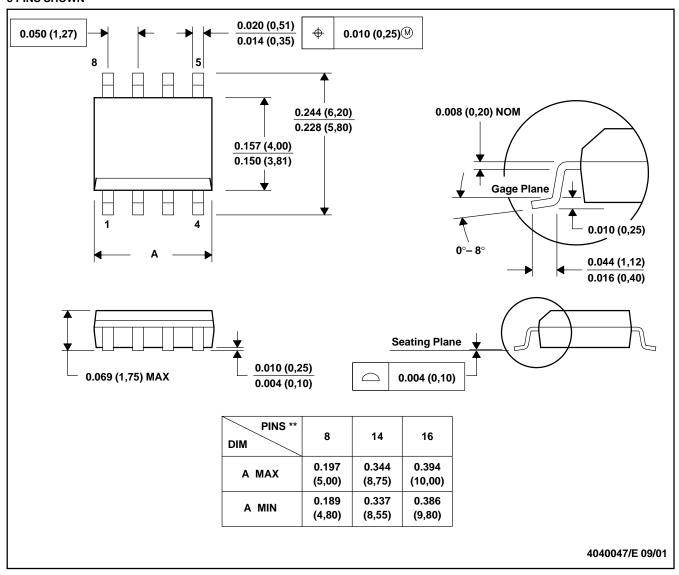
- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001

For the latest package information, go to $http://www.ti.com/sc/docs/package/pkg_info.htm$

D (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

8 PINS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-012



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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Mailing Address: Texas Instruments

Post Office Box 655303 Dallas, Texas 75265

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